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# INTERNATIONAL STANDARD



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**Metallic communication cable test methods –  
Part 4-10: Electromagnetic compatibility (EMC) – Transfer impedance and  
screening attenuation of feed-throughs and electromagnetic gaskets – Double  
coaxial test method**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

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International Standard IEC 62153-4-10 has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This second edition cancels and replaces the first edition published in 2009. It constitutes a technical revision.

The main technical changes with regard to the previous edition are as follows:

- addition of a new clause that describes a procedure for verification of the measurement set-up and further information regarding sample preparation;
- addition of a new Annex that describes how to improve measurement certainty in the very low frequency area.

The text of this standard is based on the following documents:

FDIS	Report on voting
46/563/FDIS	46/580/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62153 series, under the general title: *Metallic communication cable test methods*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

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## METALLIC COMMUNICATION CABLE TEST METHODS –

### Part 4-10: Electromagnetic compatibility (EMC) – Transfer impedance and screening attenuation of feed-throughs and electromagnetic gaskets – Double coaxial test method

#### 1 Scope

This part of IEC 62153 details a coaxial method suitable for determining the transfer impedance and/or screening attenuation of feed-throughs and electromagnetic gaskets.

The shielded screening attenuation test set-up according to IEC 62153-4-4 (triaxial method) has been modified to take into account the particularities of feed-throughs and gaskets.

A wide dynamic and frequency range can be applied to test even super screened feed-throughs and gaskets with normal instrumentation from low frequencies up to the limit of defined transversal waves in the coaxial circuits at approximately 4 GHz.

#### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

Void.